

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of: Christophe MALEVILLE et al.

Confirmation No.:

Application No: To be assigned

Group Art Unit:

Filing Date: January 8, 2004

Examiner:

For: METHOD FOR PREPARING A
SEMICONDUCTOR WAFER SURFACE

Atty. Docket No.: 4717-8400

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, Virginia 22313-1450

Sir:

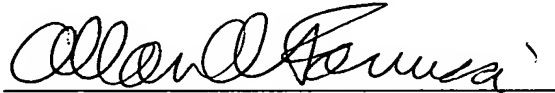
Pursuant to applicants' duty of disclosure under 37 C.F.R. 1.56, thirteen (13) references for the Examiner's review and consideration are listed on the enclosed Form PTO-1449. A copy of an International Search Report of a counterpart application is also enclosed.

Pursuant to the recent rule change in the Official Gazette, copies of the U.S. references are not submitted. It is respectfully requested that these references be made of record in this application by the Examiner's completion and return of the PTO Form 1449.

It is noted that DE 19753494 is a counterpart application to FR 2,761,526; WO 01/15215 is a counterpart application to FR 2,797,713; and US Patent No. 6,403,450 is a counterpart case to FR 2,777,115.

No fee or certification is believed to be due for this submission since the references are being submitted concurrent with the filing of this application. Should any fees be required, however, please charge such fees to Winston & Strawn LLP Deposit Account No. 50-1814.

Respectfully submitted,



Allan A. Fanucci (Reg. No. 30,256)

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Date: January 8, 2004

Enclosure

LIST OF REFERENCES CITED BY APPLICANT <i>(Use several sheets if necessary)</i>					ATTY. DOCKET NO.:		APPLICATION NO.:	
					4717-8400			
					APPLICANT:			
					Christophe MALEVILLE et al.			
					FILING DATE:		GROUP:	
U.S. PATENT DOCUMENTS								
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
	AA	5,374,564	12/1994	Bruel	437	24		
	AB	6,362,076	3/2002	Inazuki et al.	438	458		
	AC	6,372,609	4/2002	Aga et al.	438	459		
	AD	6,403,450	6/2002	Maleville et al.	438	471		
FOREIGN PATENT DOCUMENTS								
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
	AE	DE 19753494 (with English abstract)	10/1998	Germany			X	
	AF	FR 2761526 (with English abstract)	10/1998	France			X	
	AG	FR 2777115 (with English abstract)	10/1999	France			X	
	AH	FR 2797713 (with English abstract)	2/2001	France			X	
	AI	WO 01/15215 (with English abstract)	3/2001	PCT			X	
	AJ	WO 01/28000 (with English abstract)	4/2001	PCT			X	
	AK	EP 0954014	11/1999	Europe				
	AL	EP 1045448	10/2000	Europe				
	AM	EP 1158581	11/2001	Europe				
OTHER REFERENCES <i>(Including Author, Title, Date, Pertinent Pages, Etc.)</i>								
EXAMINER					DATE CONSIDERED			
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.								